

Search Notes

Application/Control No.

10/696,453

Applicant(s)/Patent under
Reexamination

HAWTOF ET AL.

Examiner

Felisa C. Hiteshew

Art Unit

1722

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------------|----------|
| 117 | 78 | 6/8/2005 | F.H. |
| 117 | 81 | 6/8/2005 | F.H. |
| 117 | 82 | 6/8/2005 | F.H. |
| 117 | 83 | 6/8/2005 | F.H. |
| 117 | 940 | 6/8/2005 | F.H. |
| | Updated | 11/30/2005 | F.H. |
| | Search | | |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|---------|----------|------------|----------|
| 117 | 78 | 11/30/2005 | F.H. |
| 117 | 81 | 11/30/2005 | F.H. |
| 117 | 83 | 11/30/2005 | F.H. |
| 117/940 | | 11/30/2005 | F.H. |

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---|----------|------|
| STN (hcaplus, inspec, japiro, uspataoo) | 6/8/2005 | F.H. |
| inventors' Name Search | 6/8/2005 | F.H. |
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